 	Notes	

Application/Control No.

10/725,381 Examiner LEE, HAN-CHOON

Applicant(s)/Patent under Reexamination

Art Unit

2813

Heather A. Doty

SEARCHED				
Class	Subclass	Date	Examiner	
438	627	8/22/2005	HD	
438	629	8/22/2005	肋	
438	630	8/22/2005	117)	
438	683	8/22/2005	15	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SEARCH	DATE	EXMR
EAST (BRS), see attached	8/22/2005	14)
Scirus, search term: atomic layer deposition titanium silicon nitride	8/22/2005	11)
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